

COMPLIANT

K1455-VB Datasheet

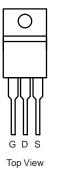
N-Channel 900V (D-S) Super Junction Power MOSFET

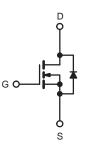
PRODUCT SUMMARY					
V _{DS} (V)	900				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	1.3			
Q _g (Max.) (nC)	200				
Q _{gs} (nC)	24				
Q _{gd} (nC)	110				
Configuration	Single				

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	900	V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$	I _D	5		
Pulsed Drain Current ^a		T _C = 100 °C	I _{DM}	3.9 21	A	
Linear Derating Factor			.0101	1.5	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	770	mJ	
Repetitive Avalanche Current ^a			I _{AR}	7.8	А	
Repetitive Avalanche Energy ^a			E _{AR}	19	mJ	
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$			PD	190	W	
Peak Diode Recovery dV/dt ^c			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
oldering Recommendations (Peak Temperature) for 10 s			300 ^d			
Mounting Torque	6-32 or M3 screw			10	lbf ∙ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 23 mH, $R_g = 25 \Omega$, $I_{AS} = 7.8$ A (see fig. 12). c. $I_{SD} \le 7.8$ A, dl/dt ≤ 140 A/µs, $V_{DD} \le 600$ V, $T_J \le 150$ °C. d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

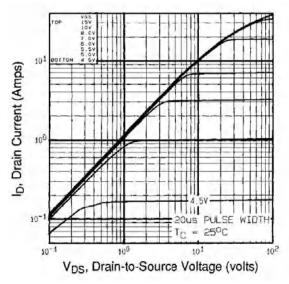


THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-		40				
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24 -			°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	-	- 0.65					
SPECIFICATIONS (T _J = 25 °C, u	nloss othorwi	so noted)						
PARAMETER	SYMBOL	1		IONS	MIN.	TYP.	MAX.	UNIT
Static	0111202						110 0 11	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0 V, I _D =	250 µA	900	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$, I _D = 1 mA	_	0.98	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}		= V _{GS} , I _D =		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20$		-	_	± 100	-
	000		= 800 V, V ₀		_	-	100	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 640 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 \text{ °C}$		_	-	500	V/°C V nA μA Ω S pF nC	μA
Drain-Source On-State Resistance	R _{DS(on)}			-	-	1.3	_	Ω
Forward Transconductance	g fs	V _{DS} =	= 100 V, I _D :	= 3.7 A ^b	5.6	-	-	S
Dynamic		<u> </u>				1	1	
Input Capacitance	C _{iss}		$V_{ab} = 0$	1	-	3100	-	
Output Capacitance	C _{oss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ - 800				800	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	f = 1.0 MHz, see fig. 5		-	490	-	
Total Gate Charge	Qg				-	-	200	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$ $I_D = 3.8 A, V_{DS} = 400 V,$		-	-	24	nC	
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^p		-	-	110	1
Turn-On Delay Time	t _{d(on)}				-	19	-	
Rise Time	t _r			-	38	-	1	
Turn-Off Delay Time	t _{d(off)}	fs $V_{DS} = 100 \text{ V}, \text{ I}_D = 3.7 \text{ A}^b$ 5.6 - iss $V_{GS} = 0 \text{ V},$ - 3100 pss $f = 1.0 \text{ MHz}, \text{ see fig. 5}$ - 800 rss $f = 1.0 \text{ MHz}, \text{ see fig. 5}$ - 490 rgs $V_{GS} = 10 \text{ V}$ $I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V},$ - - rgg $V_{GS} = 10 \text{ V}$ $I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V},$ - - - rgg $V_{GS} = 10 \text{ V}$ $I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V},$ - -		120	-	ns		
Fall Time	t _f	$R_{g} = 6.2 \Omega, R_{D} = 52 \Omega - 12^{2}$ see fig. 10 ^b		39	-			
Internal Drain Inductance	L _D	6 mm (0.25") f	from		-	5.0	-	
Internal Source Inductance	L _S	package and center of		13	-	nH		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the	bol		-	-	5.0	^
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	21	A	
Body Diode Voltage	V _{SD}	$T_{J} = 25 \ ^{\circ}C, I_{S} = 3.8 \ A, V_{GS} = 0 \ V^{b}$		-	-	1.8	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C, } I_{F} = 3.8 \text{ A,}$ dl/dt = 100 A/µs ^b		-	650	980	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	3.8	5.7	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time	is negligible (turn	-on is do	minated h	v Ls and	Ln)

Notes

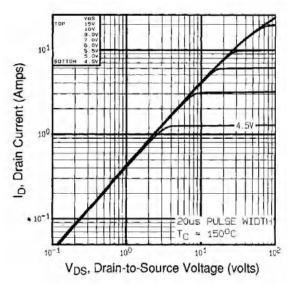
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







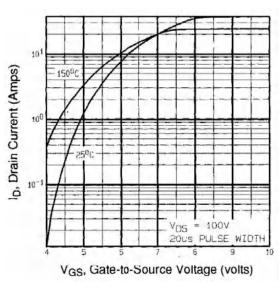
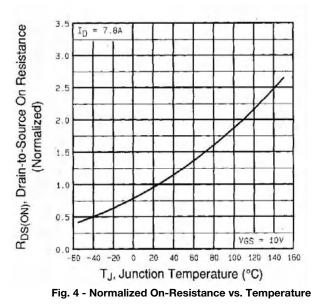


Fig. 3 - Typical Transfer Characteristics





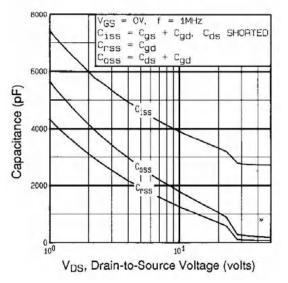


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

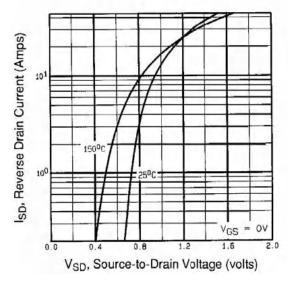


Fig. 7 - Typical Source-Drain Diode Forward Voltage

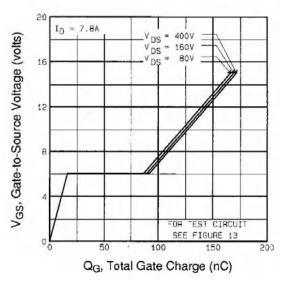
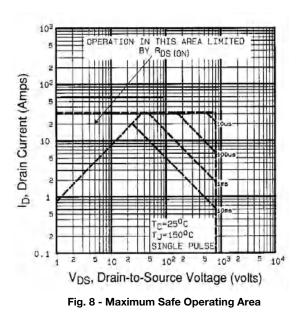


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





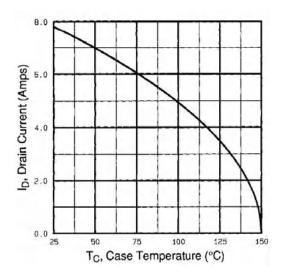


Fig. 9 - Maximum Drain Current vs. Case Temperature

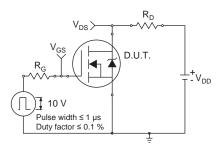


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

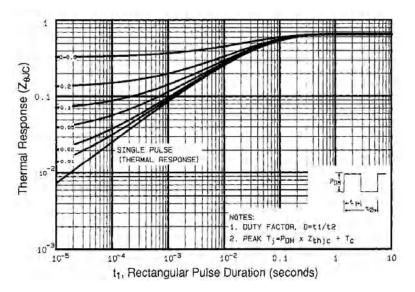


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



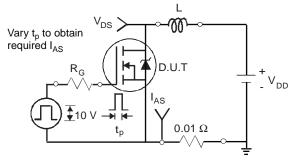


Fig. 12a - Unclamped Inductive Test Circuit

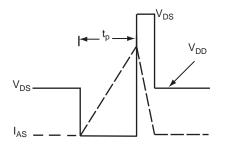


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current



Fig. 13a - Basic Gate Charge Waveform

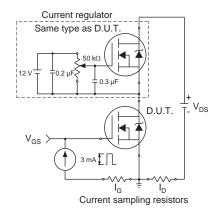
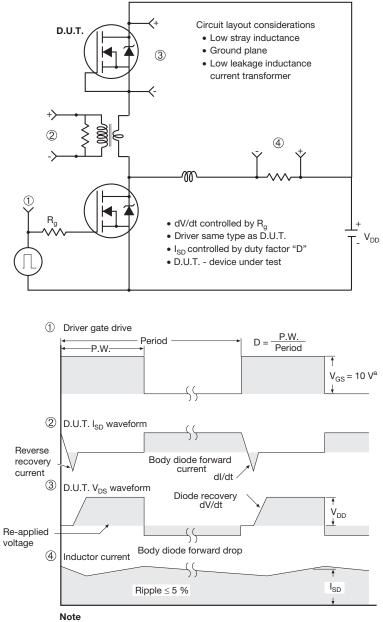


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

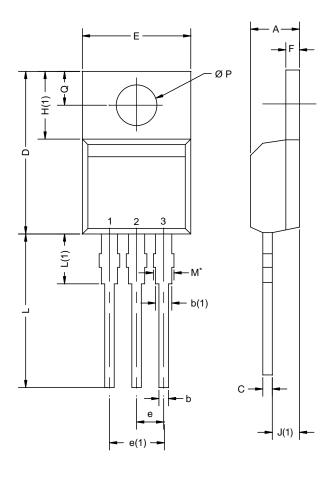


a. $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel



TO-220AB



	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØР	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12		

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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